

Search Notes

Application/Control No.

10/522,183

Examiner

LIEN TM NGO

Applicant(s)/Patent under
Reexamination

MCGILL ET AL.

Art Unit

3754

SEARCHED

Class	Subclass	Date	Examiner
222	95 105	8/6/07	cm
	181.1		
	181.2		
	181.3		
	386		
	151.3		
	642		
	333		
239	70		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR